

## Final datasheet

### Automotive CoolSiC™ MOSFET 1700 V in D2PAK

#### Features

- $V_{DSS} = 1700\text{ V}$  at  $T_{vj} = -55...175^{\circ}\text{C}$
- $I_{DDC} = 11.2\text{ A}$  at  $T_C = 25^{\circ}\text{C}$
- Optimized for fly-back topologies
- Gate-source voltage ( $V_{GS}$ ) compatible with most fly-back controllers
- Very low switching losses enabling high switching frequencies
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.5\text{ V}$
- Fully controllable  $dv/dt$  for EMI optimization
- Sense (Kelvin) source pin for better gate control and reduced switching losses
- SMT package for automated assembly and reduced system costs
- Efficiency improvement and cooling effort reduction

#### Potential applications

- DC/DC converter

#### Product validation

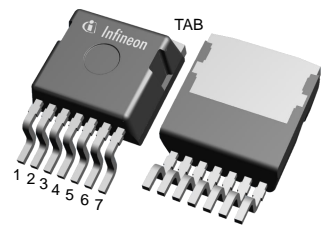
- Qualified for Automotive Applications. Product Validation according to AEC-Q100/101

#### Description

Pin definition:

- Pin 1 - Gate
- Pin 2 - Kelvin Sense Contact
- Pin 3...7 - Power Source
- Tab - Drain

Note: the source and sense pins are not exchangeable, their exchange might lead to malfunction recommended for forward operation mode only



Halogen-free



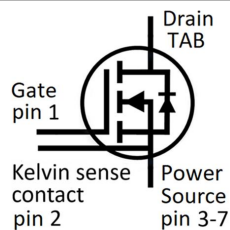
Green



Lead-free



RoHS



Type	Package	Marking
AIMBF170R650M1	PG-TO263-7-U01	A17M1650

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## 1 Package

**Table 1** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Storage temperature	$T_{stg}$		-55		150	°C
Soldering temperature	$T_{sold}$				260	°C
MOSFET/body diode thermal resistance, junction-case <sup>1)</sup>	$R_{th(j-c)}$			0.98	1.27	K/W

1) not subject to production test - verified by design/characterization

## 2 MOSFET

**Table 2** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Drain-source voltage <sup>1)</sup>	$V_{DSS}$	$T_{vj} = -55...175\text{ °C}$	1700	V	
Continuous DC drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$ <sup>2)</sup>	$I_{DDC}$	$V_{GS} = 20\text{ V}$	$T_c = 25\text{ °C}$	11.2	A
			$T_c = 100\text{ °C}$	8	
Peak drain current, $t_p$ limited by $T_{vj(max)}$ <sup>2)</sup>	$I_{DM}$	$V_{GS} = 20\text{ V}$	29	A	
Gate-source voltage, max. transient voltage <sup>3)</sup>	$V_{GS}$	$t_p \leq 0.5\ \mu\text{s}, D < 0.01$	-10/23	V	
Power dissipation, limited by $T_{vj(max)}$ <sup>2)</sup>	$P_{tot}$		$T_c = 25\text{ °C}$	118	W
			$T_c = 100\text{ °C}$	59	

1) Tested at  $T_{vj} = 25\text{ °C}$ , verified by design / characterization over full temperature range

2) Not subject to production test. Parameter verified by design / characterization

3) **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

**Table 3** Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
Recommended turn-on gate voltage	$V_{GS(on)}$		12...20	V
Recommended turn-off gate voltage	$V_{GS(off)}$		0	V

**Table 4** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 1.5 \text{ A}$	$T_{vj} = 25 \text{ °C}$ , $V_{GS(on)} = 20 \text{ V}$		350	485	mΩ
			$T_{vj} = 25 \text{ °C}$ , $V_{GS(on)} = 18 \text{ V}$		365		
			$T_{vj} = 25 \text{ °C}$ , $V_{GS(on)} = 12 \text{ V}$		545		
			$T_{vj} = 100 \text{ °C}$ , $V_{GS(on)} = 20 \text{ V}$		568		
			$T_{vj} = 175 \text{ °C}$ , $V_{GS(on)} = 20 \text{ V}$		940		
Gate-source threshold voltage	$V_{GS(th)}$	$I_D = 1.7 \text{ mA}$ , $V_{DS} = V_{GS}$ (tested after 1 ms pulse at $V_{GS} = 20 \text{ V}$ )	$T_{vj} = 25 \text{ °C}$	3.5	4.5	5.7	V
			$T_{vj} = 175 \text{ °C}$		3.6		
Zero gate-voltage drain current	$I_{DSS}$	$V_{DS} = 1700 \text{ V}$ , $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ °C}$		0.06	11	μA
			$T_{vj} = 175 \text{ °C}$		2.3		
Gate leakage current	$I_{GSS}$	$V_{DS} = 0 \text{ V}$	$V_{GS} = -10 \text{ V}$			-100	nA
			$V_{GS} = 23 \text{ V}$			100	
Forward transconductance	$g_{fs}$	$I_D = 1.5 \text{ A}$ , $V_{DS} = 20 \text{ V}$			0.65		S
Internal gate resistance	$R_{G,int}$	$f = 1 \text{ MHz}$ , $V_{AC} = 25 \text{ mV}$			25.4		Ω
Input capacitance	$C_{iss}$	$V_{DS} = 1000 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1000 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$			350		pF
Output capacitance	$C_{oss}$	$V_{DS} = 1000 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1000 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$			14		pF
Reverse transfer capacitance	$C_{rss}$	$V_{DS} = 1000 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1000 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$			0.8		pF
$C_{oss}$ stored energy	$E_{oss}$	$V_{DS} = 1000 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1000 \text{ kHz}$ , $V_{AC} = 25 \text{ mV}$			9		μJ
Total gate charge	$Q_G$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , turn-on pulse			17.5		nC
Plateau gate charge	$Q_{GS(pl)}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , turn-on pulse			4.3		nC
Gate-drain charge	$Q_{GD}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , turn-on pulse			2.7		nC
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ Ω}$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ °C}$		16.4		ns
			$T_{vj} = 175 \text{ °C}$		16		

(table continues...)

**Table 4** (continued) **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rise time	$t_r$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ } \Omega$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		8.7	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}$		9	
Turn-off delay time	$t_{d(off)}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ } \Omega$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		29	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}$		32	
Fall time	$t_f$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ } \Omega$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		35	ns
			$T_{vj} = 175 \text{ }^\circ\text{C}$		34	
Turn-on energy	$E_{on}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ } \Omega$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		44	$\mu\text{J}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		60	
Turn-off energy	$E_{off}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ } \Omega$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		9	$\mu\text{J}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		10	
Total switching energy	$E_{tot}$	$V_{DD} = 1000 \text{ V}$ , $I_D = 1.5 \text{ A}$ , $V_{GS} = 0/20 \text{ V}$ , $R_{G,ext} = 22 \text{ } \Omega$ , $L_\sigma = 20 \text{ nH}$ , diode: body diode at $V_{GS} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		53	$\mu\text{J}$
			$T_{vj} = 175 \text{ }^\circ\text{C}$		70	
Virtual junction temperature	$T_{vj(min \dots max)}$			-55	175	$^\circ\text{C}$

**Note:** Characteristics at  $T_{vj} = 25 \text{ }^\circ\text{C}$ , unless otherwise specified.

### 3 Body diode (MOSFET)

**Table 5** **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	$V_{DSS}$	$T_{vj} = -55 \dots 175 \text{ }^\circ\text{C}$	1700	V

**(table continues...)**

3 Body diode (MOSFET)

**Table 5 (continued) Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit	
Continuous reverse drain current for $R_{th(j-c,max)}$ , limited by $T_{vj(max)}$	$I_{SDC}$	$V_{GS} = 0 V$	$T_c = 25 °C$	10.2	A
			$T_c = 100 °C$	10	
Peak reverse drain current, $t_p$ limited by $T_{vj(max)}$	$I_{SM}$	$V_{GS} = 0 V$	10.2	A	

**Table 6 Characteristic values**

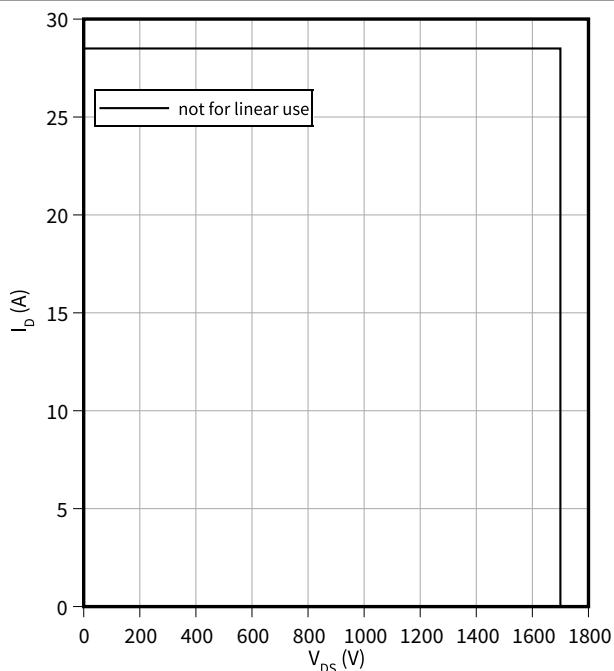
Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source reverse voltage	$V_{SD}$	$I_{SD} = 1.5 A, V_{GS} = 0 V$	$T_{vj} = 25 °C$	3.2	5	V
			$T_{vj} = 100 °C$	3.1		
			$T_{vj} = 175 °C$	3		
MOSFET forward recovery charge	$Q_{fr}$	$V_{DD} = 1000 V,$ $I_{SD} = 1.5 A, V_{GS} = 0 V,$ $-di_{SD}/dt = 1000 A/\mu s, Q_{fr}$ includes also $Q_C$	$T_{vj} = 25 °C$	24.2		nC
			$T_{vj} = 175 °C$	42.9		
MOSFET peak forward recovery current	$I_{frm}$	$V_{DD} = 1000 V,$ $I_{SD} = 1.5 A, V_{GS} = 0 V,$ $-di_{SD}/dt = 1000 A/\mu s, Q_{fr}$ includes also $Q_C$	$T_{vj} = 25 °C$	4.8		A
			$T_{vj} = 175 °C$	6.7		
Virtual junction temperature	$T_{vj(min \dots max)}$		-55		175	°C

## 4 Characteristics diagrams

### Reverse bias safe operating area (RBSOA)

$$I_D = f(V_{DS})$$

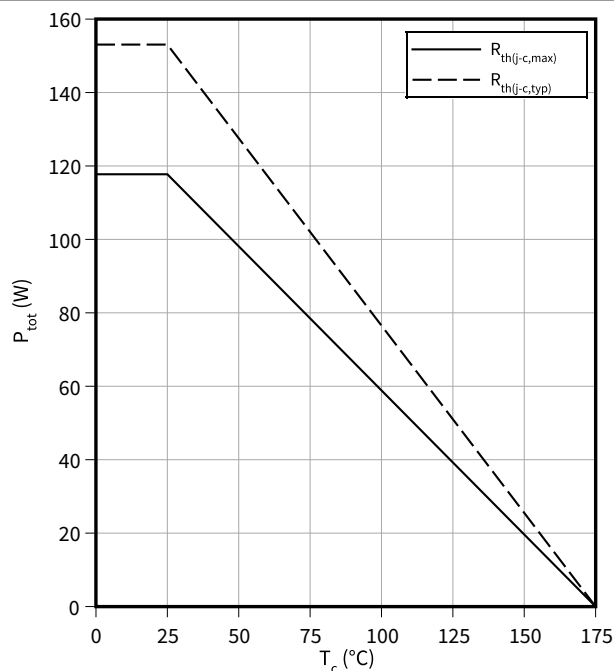
$$T_{vj} < 175\text{ °C}, V_{GS} = 0/20\text{ V}, T_c = 25\text{ °C}$$



### Power dissipation as a function of case temperature

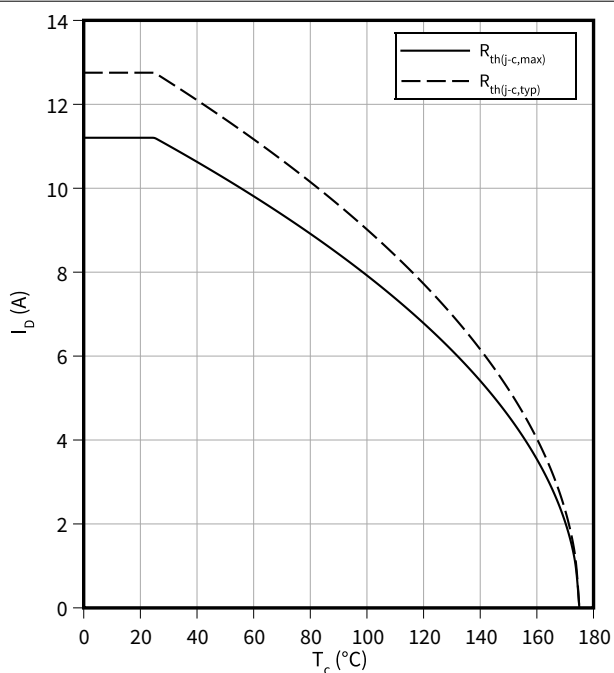
$$P_{tot} = f(T_c)$$

$$T_{vj} \leq 175\text{ °C}$$



### Maximum DC drain to source current as a function of case temperature

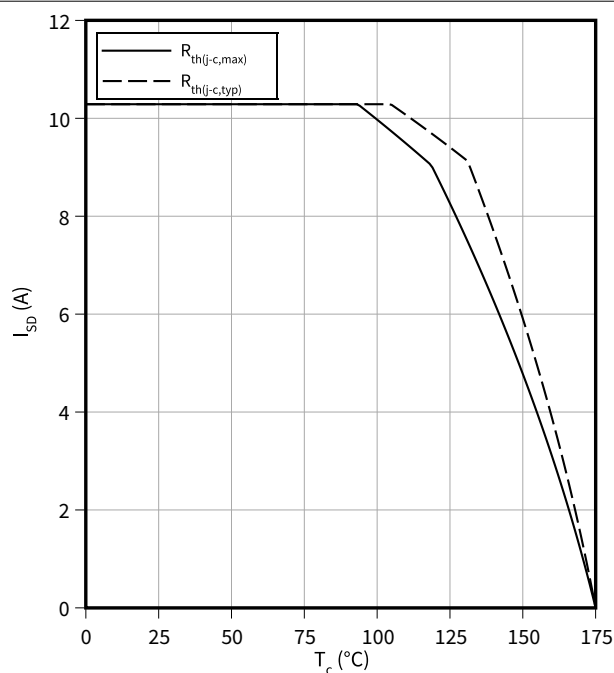
$$I_D = f(T_c)$$



### Maximum source to drain current as a function of case temperature

$$I_{SD} = f(T_c)$$

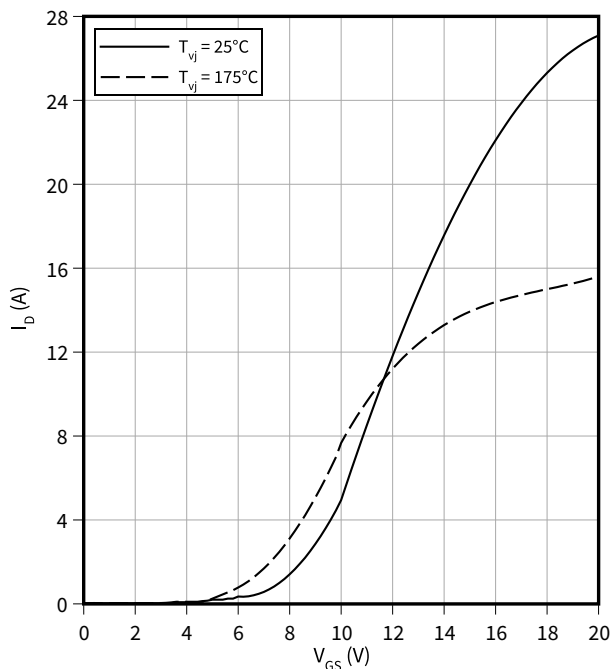
$$V_{GS} = 0\text{ V}$$



4 Characteristics diagrams

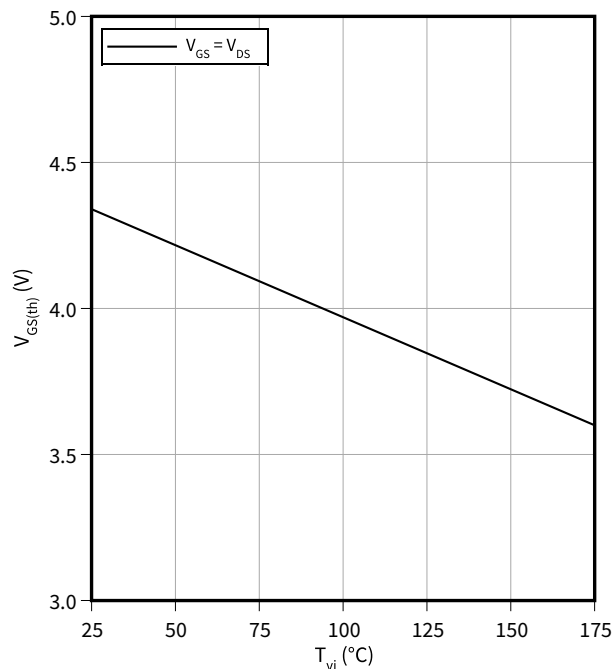
**Typical transfer characteristic**

$I_D = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$ ,  $t_p = 20\ \mu\text{s}$



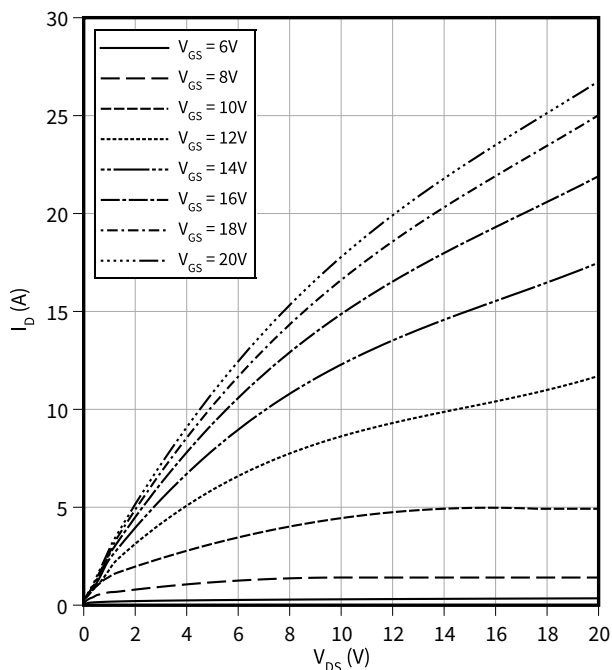
**Typical gate-source threshold voltage as a function of junction temperature**

$V_{GS(th)} = f(T_{vj})$   
 $I_D = 1.7\text{ mA}$



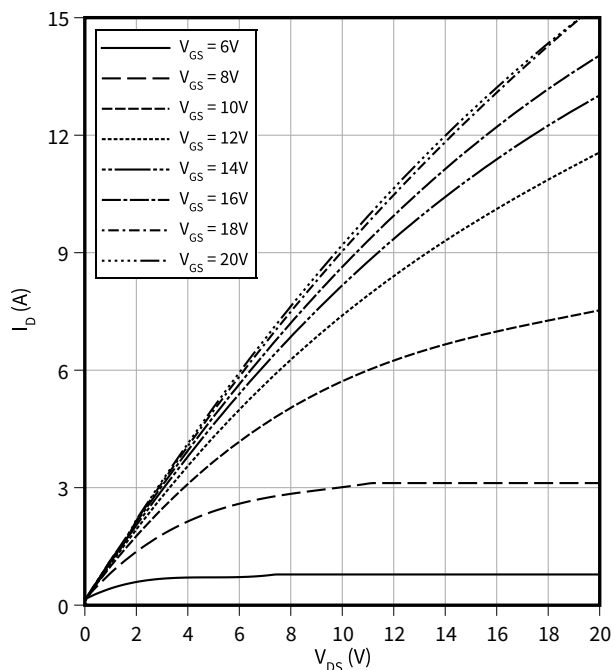
**Typical output characteristic,  $V_{GS}$  as parameter**

$I_D = f(V_{DS})$   
 $T_{vj} = 25\ ^\circ\text{C}$ ,  $t_p = 20\ \mu\text{s}$



**Typical output characteristic,  $V_{GS}$  as parameter**

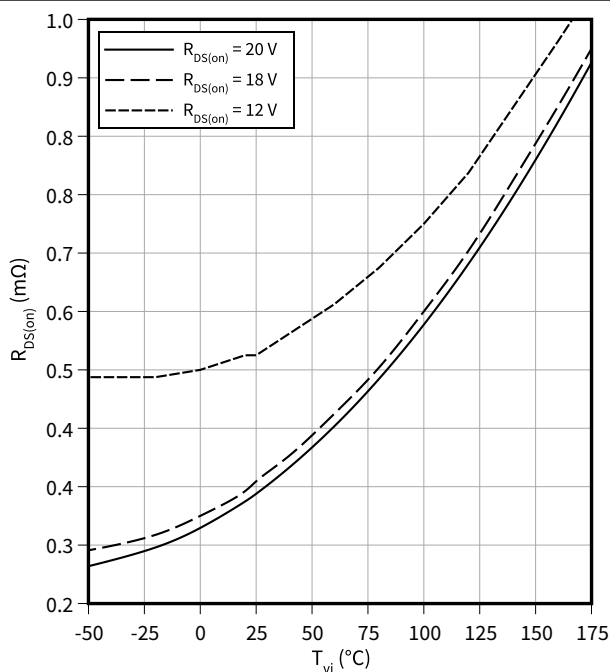
$I_D = f(V_{DS})$   
 $T_{vj} = 175\ ^\circ\text{C}$ ,  $t_p = 20\ \mu\text{s}$



4 Characteristics diagrams

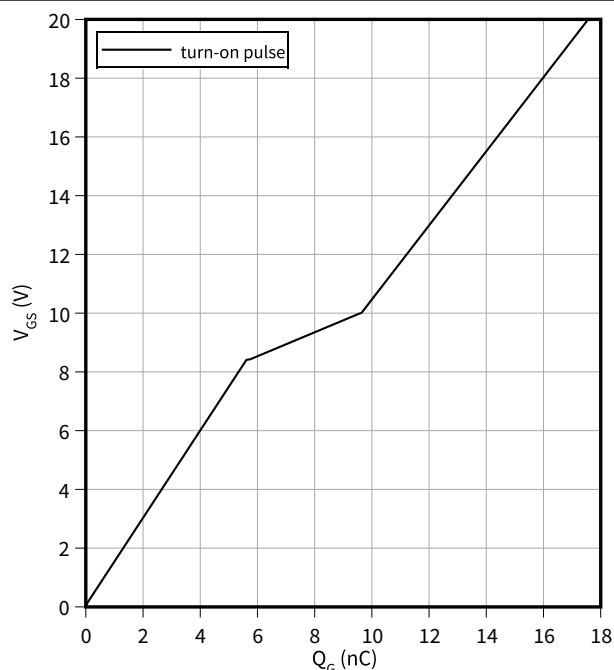
**Typical on-state resistance as a function of junction temperature**

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 1.5 \text{ A}$



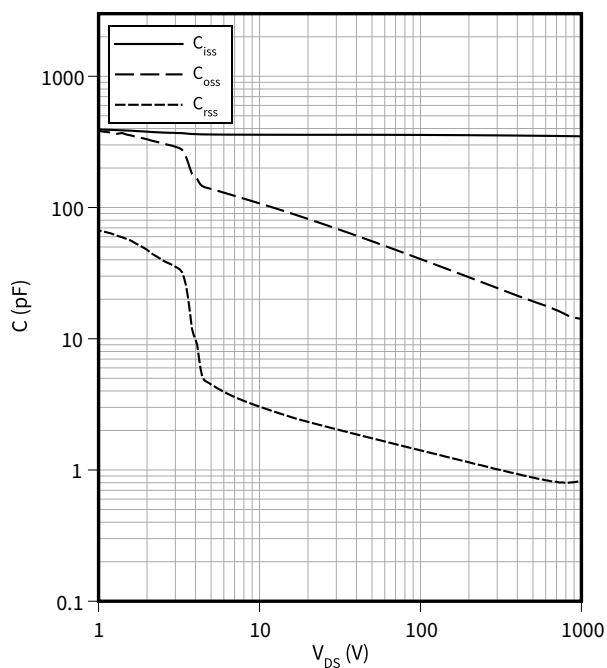
**Typical gate charge**

$V_{GS} = f(Q_G)$   
 $I_D = 1.5 \text{ A}, V_{DS} = 1000 \text{ V}$



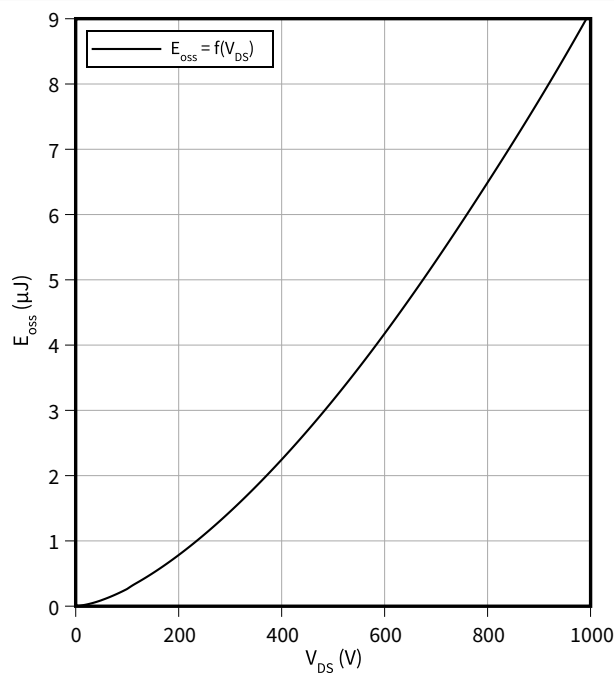
**Typical capacitance as a function of drain-source voltage**

$C = f(V_{DS})$   
 $f = 1000 \text{ kHz}, V_{GS} = 0 \text{ V}$



**Typical  $C_{oss}$  stored energy**

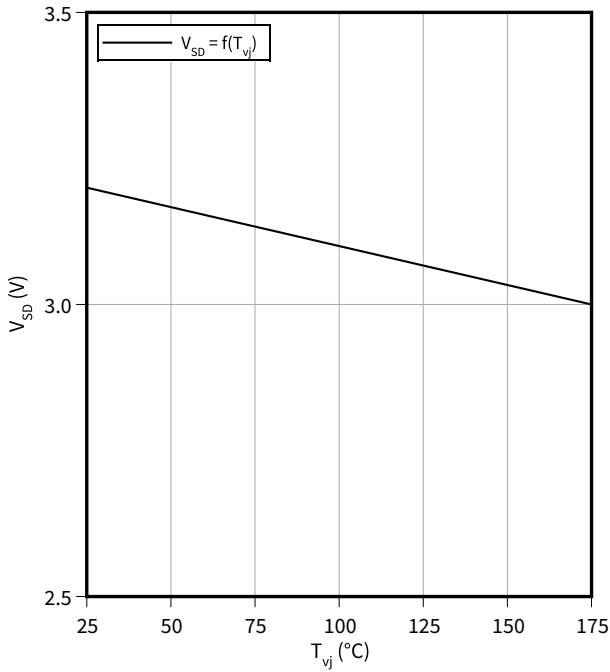
$E_{oss} = f(V_{DS})$   
 $f = 1000 \text{ kHz}, V_{GS} = 0 \text{ V}$



4 Characteristics diagrams

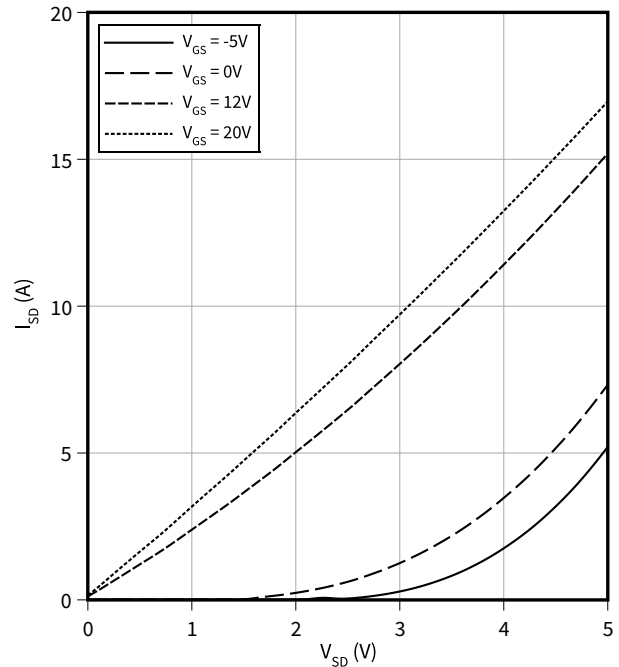
**Typical reverse drain voltage as function of junction temperature**

$V_{SD} = f(T_{vj})$   
 $I_{SD} = 1.5 \text{ A}, V_{GS} = 0 \text{ V}$



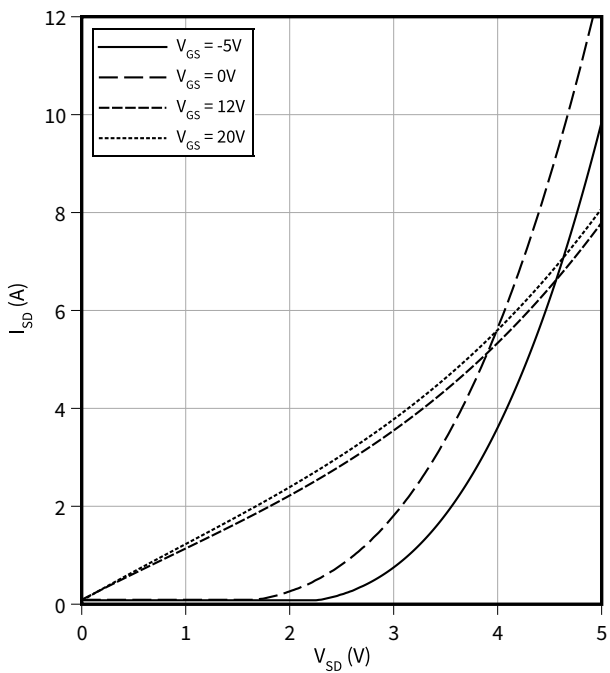
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25 \text{ °C}, t_p = 20 \mu\text{s}$



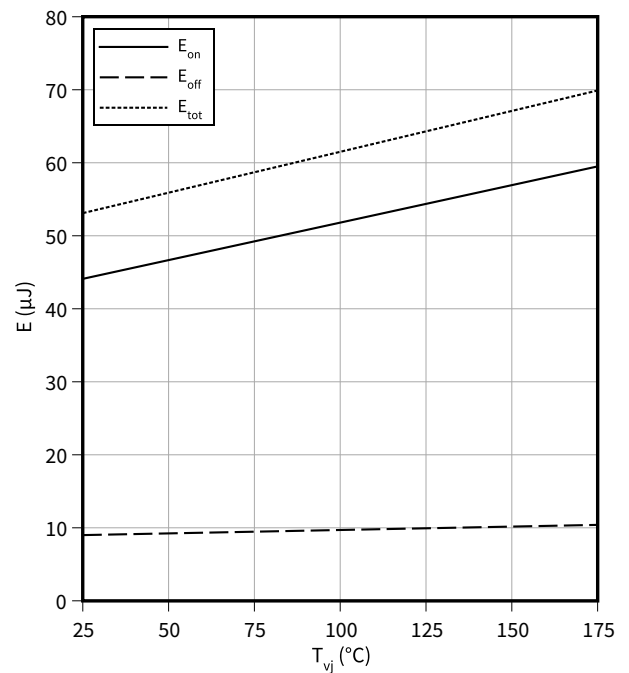
**Typical reverse drain current as function of reverse drain voltage,  $V_{GS}$  as parameter**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 175 \text{ °C}, t_p = 20 \mu\text{s}$



**Typical switching energy as a function of junction temperature, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0 \text{ V}$**

$E = f(T_{vj})$   
 $V_{GS} = 0/20 \text{ V}, I_D = 1.5 \text{ A}, R_{G,ext} = 22 \Omega, V_{DD} = 1000 \text{ V}$

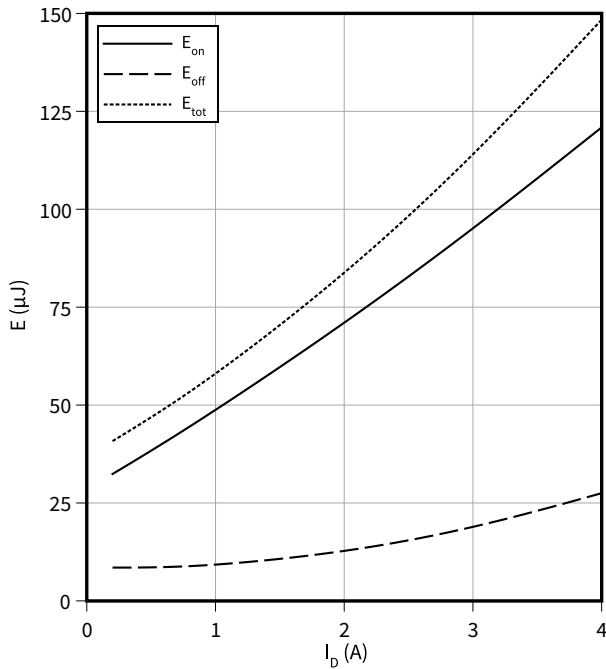


4 Characteristics diagrams

**Typical switching energy as a function of drain current, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(I_D)$

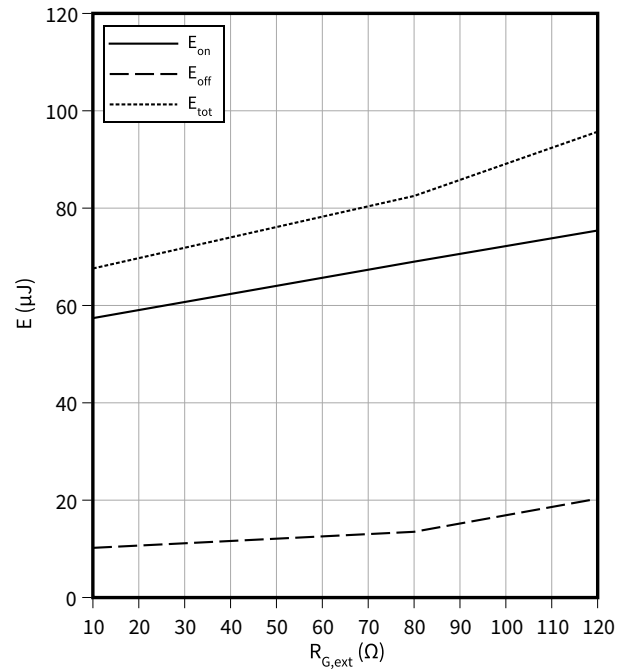
$V_{GS} = 0/20\text{ V}$ ,  $T_{vj} = 175\text{ °C}$ ,  $R_{G,ext} = 22\ \Omega$ ,  $V_{DD} = 1000\text{ V}$



**Typical switching energy as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$E = f(R_{G,ext})$

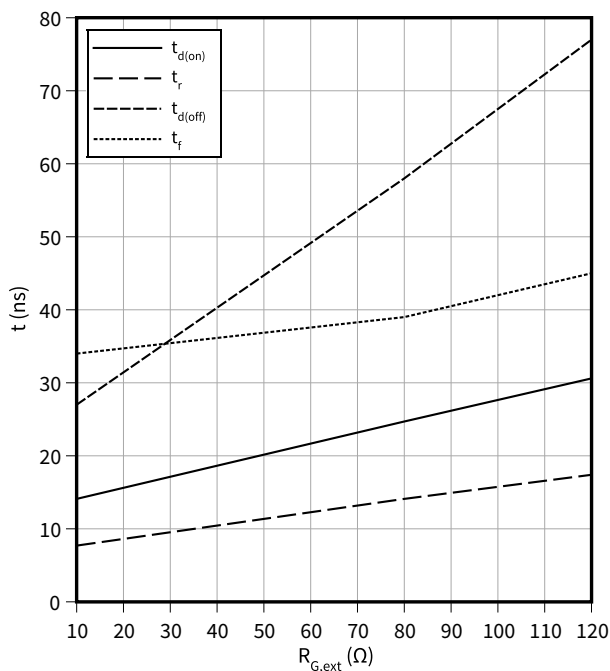
$V_{GS} = 0/20\text{ V}$ ,  $I_D = 1.5\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 1000\text{ V}$



**Typical switching times as a function of gate resistance, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$t = f(R_{G,ext})$

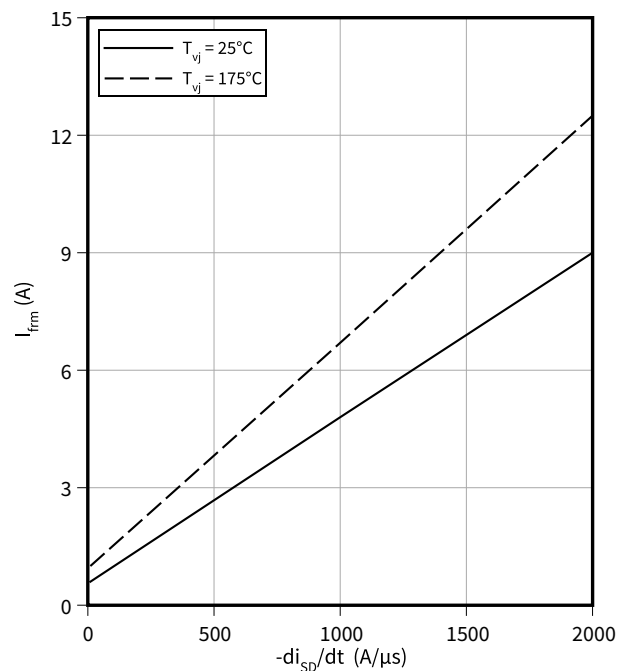
$V_{GS} = 0/20\text{ V}$ ,  $I_D = 1.5\text{ A}$ ,  $T_{vj} = 175\text{ °C}$ ,  $V_{DD} = 1000\text{ V}$



**Typical reverse recovery current as a function of reverse drain current slope, test circuit in Fig. F, 2nd device own body diode:  $V_{GS} = 0\text{ V}$**

$I_{frm} = f(-di_{SD}/dt)$

$V_{GS} = 0/20\text{ V}$ ,  $I_{SD} = 1.5\text{ A}$ ,  $V_{DD} = 1000\text{ V}$

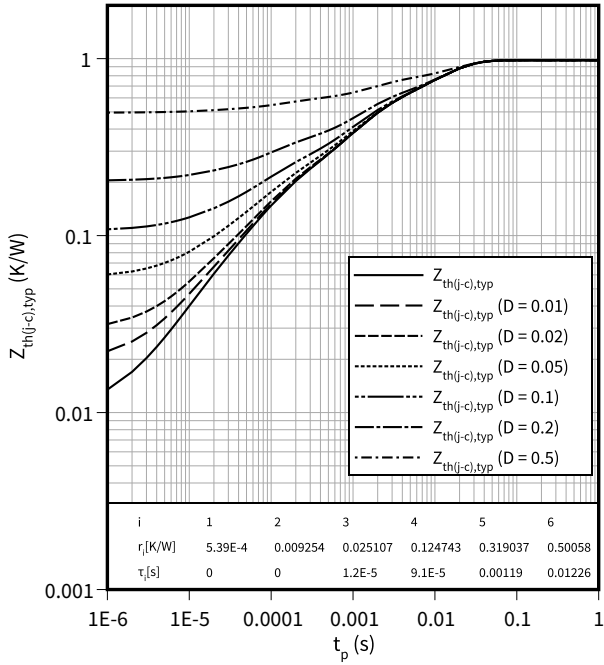


4 Characteristics diagrams

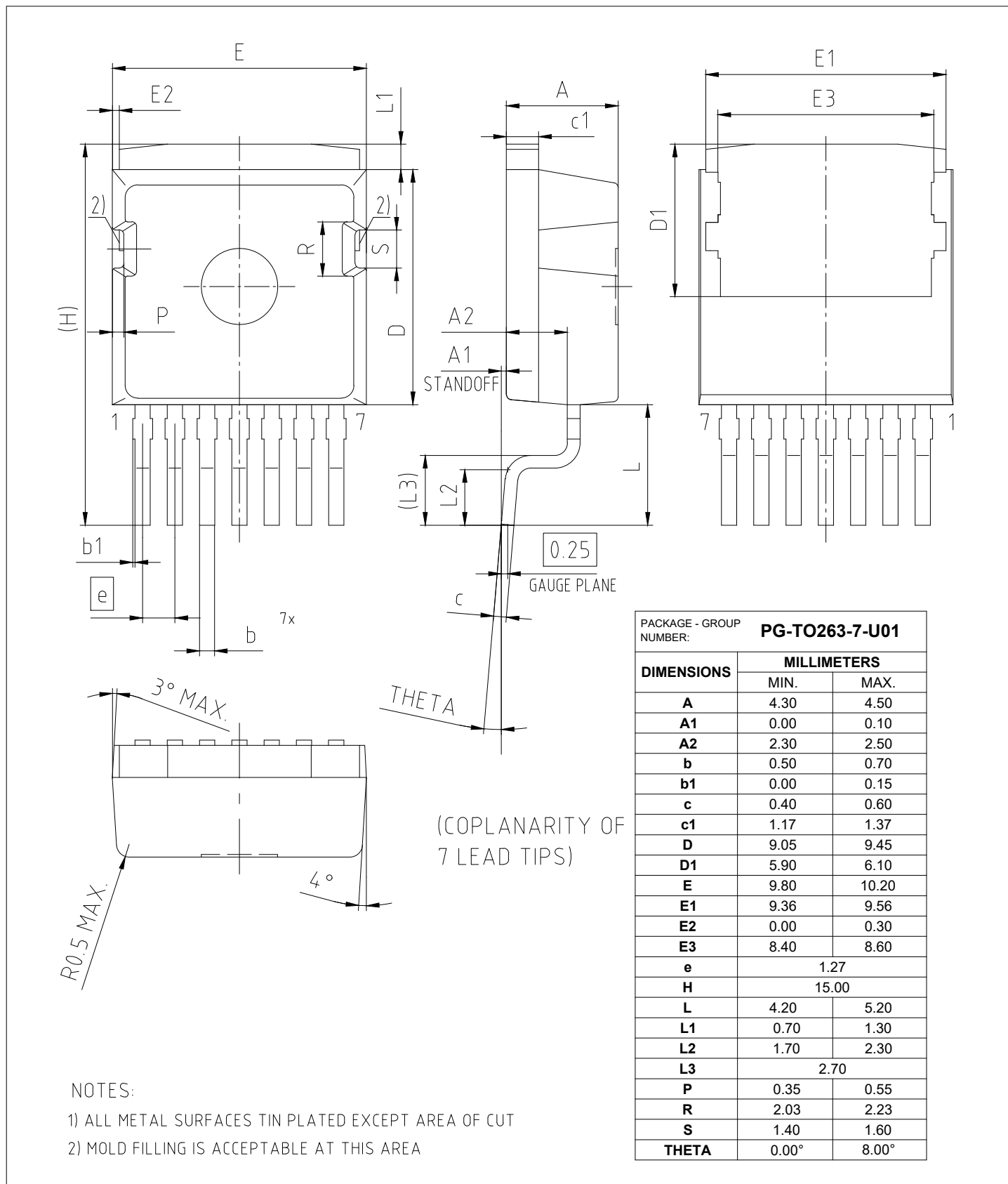
**Typ. transient thermal impedance (MOSFET/diode)**

$$Z_{th(j-c),typ} = f(t_p)$$

$$D = t_p/T$$

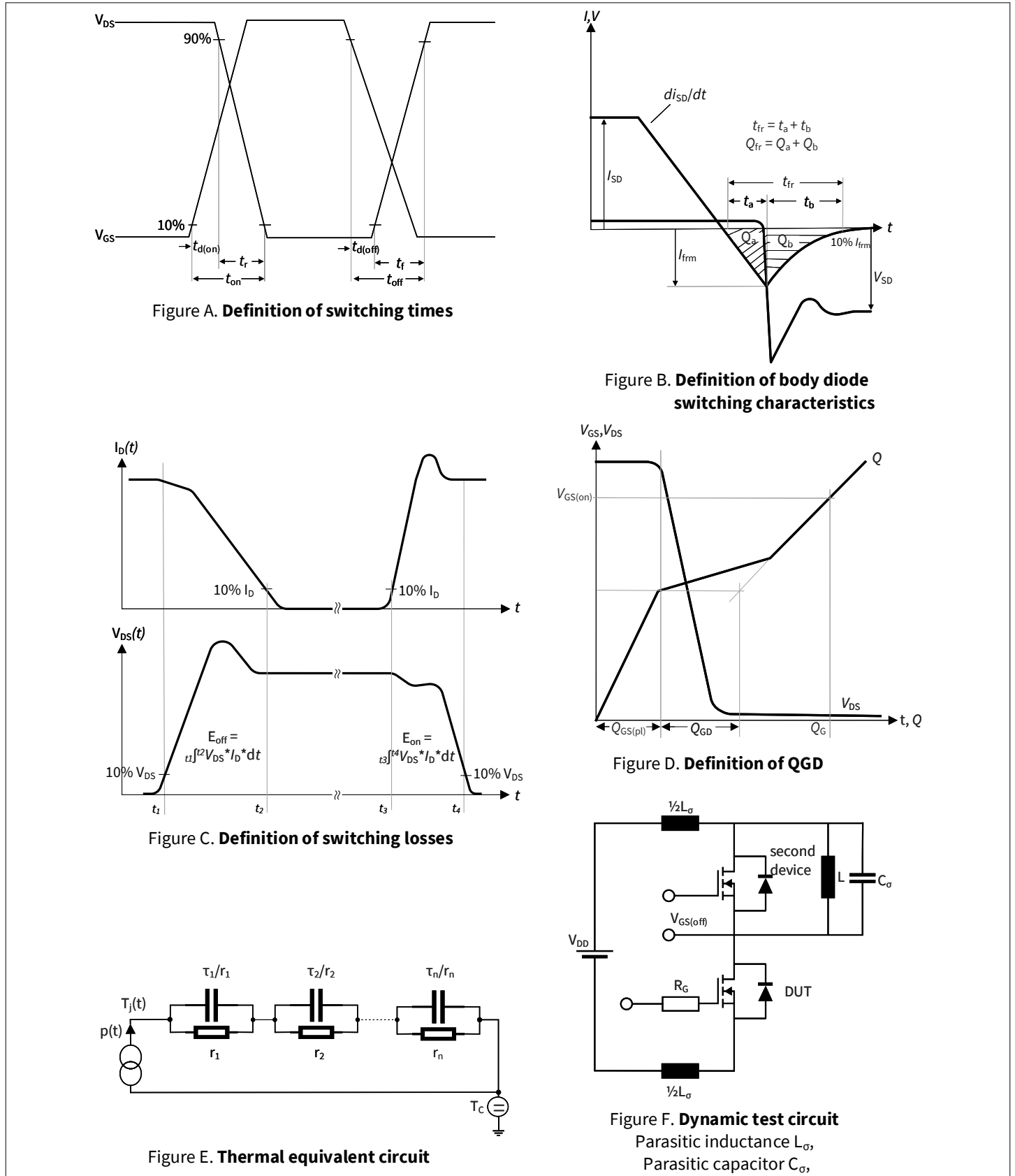


**5 Package outlines**



**Figure 1**

## 6 Testing conditions



**Figure 2**

## Revision history

Document revision	Date of release	Description of changes
0.10	2024-11-14	Target datasheet
0.20	2025-12-11	Preliminary datasheet
1.00	2026-03-03	Final datasheet

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